

**Search Notes**

Application/Control No.

10/622,182

Examiner

Jezia Riley

Applicant(s)/Patent under  
Reexamination

VAN NESS ET AL.

Art Unit

1637

**SEARCHED**

Class	Subclass	Date	Examiner
435	6 7.1, 7.2		
436	518, 536	10/29/2006	JR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN search enclosed	10/24/2006	JR